Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/719,477	CHEN ET AL.	
Examiner	Art Unit	_
II IA OLIEBENICKI	1644	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH (INCLUDING SEAF)
	DATE	EXMR
WEST: attached	7/3/2006	I.O.
Dialog: same as WEST	7/3/2006	I.O.
Inventor search	7/3/2006	I.O.
Priority applications	7/3/2006	I.O.